

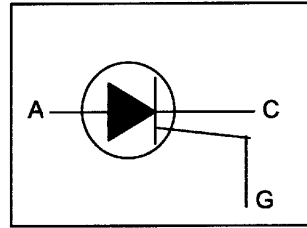
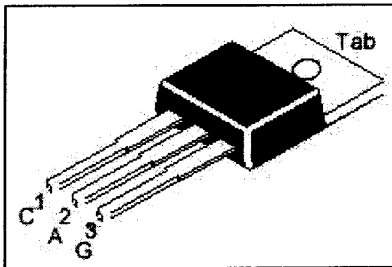
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**THYRISTORS**

**BT151**



**TO-220  
 Plastic Package**

**For use in Applications Requiring high Bidirectional Blocking Voltage Capability and high Thermal Cycling Performance. Typical Applications include Motor Control, Industrial and Domestic Lighting, Heating and Static Switching**

**ABSOLUTE MAXIMUM RATINGS**

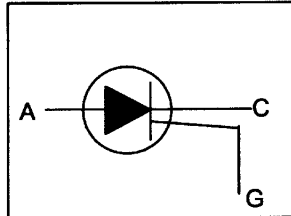
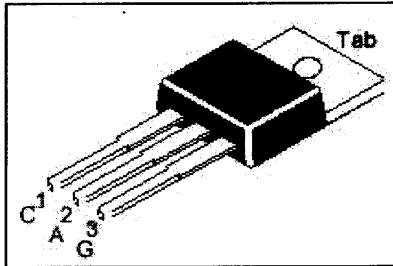
PARAMETER	SYMBOL	TEST CONDITION	VALUE		UNIT
			500	650	
		<b>BT151-</b>	<b>500</b>	<b>650</b>	
Repetitive Peak Off State Voltage	$V_{DRM}, V_{RRM}$		*500	*650	V
Average On State Current	$I_T(AV)$	half sine wave, $T_{mb} \leq 109^\circ C$	7.5		A
RMS On State Current	$I_T(RMS)$	all conduction angles	12		A
Non Repetitive Peak On State Current	$I_{TSM}$	half sine wave, $T_J=25^\circ C$ prior to surge $t=10ms$	100		A
		$t=8.3ms$	110		A
$I^2t$ for Fusing	$I^2t$	$t=10ms$	50		$A^2s$
Repetitive Rate of Rise of On State Current After Triggering	$di_T/dt$	$I_{TM}=20A, I_G=50mA,$ $di_G/dt=50mA/\mu s$	50		$A/\mu s$
Peak Gate Current	$I_{GM}$		2.0		A
Peak Gate Voltage	$V_{GM}$		5.0		V
Peak Reverse Gate Voltage	$V_{RGM}$		5.0		V
Peak Gate Power	$P_{GM}$		5.0		W
Average Gate Power	$P_G(AV)$	Over any 20ms period	0.5		W
Storage Temperature	$T_{stg}$		- 40 to +150		$^\circ C$
Operating Junction Temperature	$T_J$		125		$^\circ C$

**THERMAL RESISTANCE**

Junction to Mounting Base	$R_{th(j-mb)}$		1.3 max	K/W
Junction to Ambient	$R_{th(j-a)}$	in free air	60 typ	K/W

\*Although not recommended, off state voltage upto 800V may be applied without damage, but the thyristor may switch to the on state. The rate of rise of current should not exceed 15A/ $\mu s$

**Quality Semi-Conductors**



**ELECTRICAL CHARACTERISTICS ( $T_J=25^\circ\text{C}$  unless specified otherwise)**

PARAMETER	SYMBOL	TEST CONDITION	MIN	MAX	UNIT
Gate Trigger Current	$I_{GT}$	$V_D=12\text{V}, I_T=0.1\text{A}$		15	mA
Latching Current	$I_L$	$V_D=12\text{V}, I_{GT}=0.1\text{A}$		40	mA
Holding Current	$I_H$	$V_D=12\text{V}, I_{GT}=0.1\text{A}$		20	mA
On State Voltage	$V_T$	$I_T=23\text{A}$		1.75	V
Gate Trigger Voltage	$V_{GT}$	$V_D=12\text{V}, I_T=0.1\text{A}$ $V_D=V_{DRM}(\text{max}),$ $I_T=0.1\text{A}, T_J=125^\circ\text{C}$	0.25	1.5	V
Off State Leakage Current	$I_D, I_R$	$V_D=V_{DRM}(\text{max}),$ $V_R=V_{RRM}(\text{max}) T_J=125^\circ\text{C}$		0.5	mA

**DYNAMIC CHARACTERISTICS**

PARAMETER	SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNIT
Critical Rate of Rise of Off State Voltage	$dV_D/dt$	$V_{DM}=67\% V_{DRM}(\text{max}),$ $T_J=125^\circ\text{C},$ exponential waveform gate open circuit $R_{GK}=100\Omega$	50 200			$\text{V}/\mu\text{s}$ $\text{V}/\mu\text{s}$
Gate Controlled Turn On time	$t_{gt}$	$I_{TM}=40\text{A}, V_D=V_{DRM}(\text{max}),$ $I_G=0.1\text{A}, dI_G/dt=5\text{A}/\mu\text{s}$		2.0		$\mu\text{s}$
Circuit Commutated Turn Off time	$t_q$	$V_D=67\% V_{DRM}(\text{max}),$ $T_J=125^\circ\text{C}, I_{TM}=20\text{A}, V_R=25\text{V},$ $dI_{TM}/dt=30\text{A}/\mu\text{s},$ $dV_D/dt=50\text{V}/\mu\text{s}, R_{GK}=100\Omega$		70		$\mu\text{s}$

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